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L Number	Hits	Search Text	DB	Time stamp
-	317	(257/190).CCLS.	USPAT; US-PGPUB; EPO; JPO;	2002/08/14 17:14
-	2834	(si silicon) and perovskite	IBM_TDB USPAT; US-PGPUB; EPO; JPO;	2002/06/09 16:16
_	6	(si silicon) and perovskite and ((257/190).CCLS.)	IBM_TDB USPAT; US-PGPUB; EPO; JPO;	2002/06/09 16:16
_	1	"5484664".PN.	IBM_TDB USPAT	2002/06/09
-	1	"5741724".PN.	USPAT	2002/06/09
-	1	("6392257").PN.	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/08/14 17:15
-	0	6392257.URPN.	USPAT	2002/08/14
_	107	(Ramdani-Jamal\$ Droopad-Ravindranath\$ Hilt-Lyndee\$ Eisenbeiser-Kurt\$).in.	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/08/14 17:16
-	1	"5879956".PN.	USPAT	2002/08/14 17:19
	3	((monocrystal\$ (mono single) adj (crystal crystalline)) near5 perovskite) SAME (sio siox silicon adj (dioxide oxide))	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/09/05
~	1	(monocrystal\$ (mono single) adj (crystal crystalline)) near5 ((sto perovskite) and (iii-v gaas algas inp gan))	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/09/05 10:58
_	76	(monocrystal\$ (mono single) adj (crystal crystalline)) SAME ((sto srtio perovskite) and (iii-v gaas algas inp gan))	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/09/05 12:30
-	4	("4987472" "5608749" "5625202" "5701321").PN.	USPAT	2002/09/05 11:20
_	2	(SERIZAWA-HIROMOTO\$ FUKAI-SHOICHI\$).in. and perovskite	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2002/09/05 12:31
-	169	(SERIZAWA-HIROMOTO\$ FUKAI-SHOICHI\$).in.	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/09/05 14:24
-	1	("6270568").PN.	USPAT; US-PGPUB; EPO; JPO; IBM TDB	2002/09/05 14:24

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[Abstract] [PDF Full-Text (336 KB)] CNF

3 **Device characteristics of crystalline epitaxial oxides on silicon** *Kaushik, V.; Eisenbeiser, K.; Nguyen, B.-Y.; Finder, J.; Yu, Z.; Ramdani, J R.; Curless, J.; Overgaard, C.; Prabhu, L.; Conner, J.* Device Research Conference, 2000. Conference Digest. 58th DRC, 2000 Page(s): 17 -20

[Abstract] [PDF Full-Text (260 KB)] CNF

4 Photovoltaic properties of the Bi/sub 4/Ti/sub 3/O/sub 12//Si heterostructures

Pintilie, L.; Pintilie, I.; Alexe, M. Semiconductor Conference, 1999. CAS '99 Proceedings. 1999 Internationa

58th Annual Device Research Conference



58th ANNUAL DEVICE RESEARCH CONFERENCE June 19-21, 2000 · Denver, Colorado



The 58th Annual Device Research Conference will be held June 19-21, 2000, at the <u>University of Denver</u>, Denver, Colorado

The <u>DRC</u> brings together scientists, engineers, and students to discuss new and exciting breakthroughs and advances in the field of device research. The <u>DRC</u> is sponsored by the <u>IEEE Electron Devices</u>
<u>Society</u>. The conference will be held at <u>University of Denver</u>, Denver,



Colorado from Monday, June 19 through Wednesday, June 21. The DRC and the <u>Electronic Materials Conference</u> (EMC) of the <u>TMS</u> will again coordinate activities. The <u>EMC</u> will be held at the same location on June 21-23, 2000. Device-oriented papers should be submitted to the <u>DRC</u> and materials-oriented papers to the <u>EMC</u>.

Registration forms and information on accommodations can be obtained from the Local Arrangement Chair or at the <u>DRC</u> web site. Early registration is encouraged with a reduced registration fee offered as an incentive. Students also will receive a reduced registration fee. Limited travel funds are available to students presenting papers. Further information on student assistance may be obtained by writing to Mark Rodder (<u>m-rodder@ti.com</u>).

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The on-line secure registration form is available for electronic submission, or the form may be downloaded in a portable document format and viewed using Adobe Acrobat. Registration information includes a description of registration policies and options. General information includes other policies and answers to common questions.

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